

AMENDMENTS TO THE SPECIFICATION

Please amend paragraph [0050] as follows:

[0050] FIG. 8 is a flow chart of another exemplary method of fabricating a liquid crystal display device according to the present invention. In FIG. 8, steps S301-S309 may include processes similar to those of FIG. 5. However, step S308 may include an additional lighting test that may detect line defects or driving defects of thin film transistors by forming an additional testing terminal along an outer portion of the upper and lower substrates and applying a signal to the terminal while observing the transmitted light using the second polarizer 180b. However, since the gap between the attached upper and lower substrates may be very narrow (i.e., a few μm), it may be difficult to form the testing terminal and to apply the signal from an exterior of the panel. Thus, the lighting test may not be performed. In order to solve these problems, the testing terminals may be formed along side surfaces of the TFT array substrate and the color filter substrate to be exposed after attaching upper and lower substrates after the liquid crystal dispensing process. Accordingly, the eye test and the lighting test may be performed simultaneously before the cutting and dividing processes to prevent generation of inferior liquid crystal panels.